Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	5393	356/237.1-237.5.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 07:49
L2	14	1 and aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:07
L3	8	2 and reticle	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:33
L4	0	3 and transfer adj2 functions	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:35
L5	0	4 and transfer adj2 functions	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:40
L6	14	1 and modulation adj2 transfer adj2 function	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:56
L7	5	1 and inspect\$3 adj2 system same exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:38
L8	2514	aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:39
L9	270	8 and exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:34
L10	0	9 and mtp	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:08

L11	2	9 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:12
.L12	71	inspect\$3 adj2 system same exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20
L13	10	12 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:18
L14	0	1 and different adj3 wavelength same exposure adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:16
L15	101	different adj3 wavelength same exposure adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:16
L16	0	15 and inspect\$3 adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:17
L17	0	15 and inspect\$3 adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:17
L18	1	15 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20
L19	17253	inspect\$3 adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20
L20	276	19 and exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20

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L21	. 11	20 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OK	ON	2005/10/18 09:21
L22	55	20 and different adj2 wavelength	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:22
L23	75	8 and exposure adj2 system same wavelength	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	ÖR.	ON	2005/10/18 11:35
L24	29	equal adj3 mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:36
L25	54	1 and inspect\$3 adj2 system same lithograph\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:38
L26	2	25 and aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:33
L27	116534	lithograph\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:34
L28	1101	27 and aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:34
L29	21	28 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:44
L30	311	28 and defect	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:44

L31	21	29 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:44
L32	0	31 not 29	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 13:44
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L3	8	2 and reticle	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:33
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L5	0	4 and transfer adj2 functions	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:40
L6	14	1 and modulation adj2 transfer adj2 function	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:56
L7	5	1 and inspect\$3 adj2 system same exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:11
L8	2514	aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:07
L9	270	8 and exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:34
L10	0	9 and mtp	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:08

L11	2	9 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:12
L12	71	inspect\$3 adj2 system same exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20
L13	10	12 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:18
L14	Ō	1 and different adj3 wavelength same exposure adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:16
L15	101	different adj3 wavelength same exposure adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:16
L16	0	15 and inspect\$3 adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:17
L17	0	15 and inspect\$3 adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:17
L18	1	15 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20
L19	17253	inspect\$3 adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20
L20	276	19 and exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:20

L21	11	20 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:21
L22	55	20 and different adj2 wavelength	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:22
L23	75	8 and exposure adj2 system same wavelength	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:34
S1	2	("5696591").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/17 07:07

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L3	8	2 and reticle	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:33
L4	0	3 and transfer adj2 functions	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:35
L5		4 and transfer adj2 functions	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:40
L6	14	1 and modulation adj2 transfer adj2 function	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 08:56
L7	5	1 and inspect\$3 adj2 system same exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR ·	ON	2005/10/18 11:38
L8	2514	aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:39
L9	270	8 and exposure adj2 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:34
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L13	10	12 and mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:18
L14	0	1 and different adj3 wavelength same exposure adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:16
L15	101	different adj3 wavelength same exposure adj3 system	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 09:16
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L24	29	equal adj3 mtf	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:36
L25	54	1 and inspect\$3 adj2 system same lithograph\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:38
L26	2	25 and aerial adj2 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/18 11:39
S1	2	("5696591").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/05/17 07:07

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2	INZZ	1 AND mtf	unrestricted	14	<u>show titles</u>
3	INZZ	1 AND defect	unrestricted	93	show titles
4	INZZ	3 AND inspection	unrestricted	49	show titles
5	INZZ	equal ADJ mtf	unrestricted	3	show titles
6	INZZ	lithography	unrestricted	28124	show titles
7	INZZ	6 AND defect	unrestricted	1135	show titles
8	INZZ	7 AND aerial ADJ image	unrestricted	79	show titles
9	INZZ	8 AND mtf	unrestricted	1	show titles

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<u>#5</u>	(((aerial image <in>metadata))<and>(exposure<in>metadata))</in></and></in>	7
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<u>#17</u>	(mtf <in>metadata)</in>	308
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